Am29LV040B

Data Sheet



July 2003

The following document specifies Spansion memory products that are now offered by both Advanced Micro Devices and Fujitsu. Although the document is marked with the name of the company that originally developed the specification, these products will be offered to customers of both AMD and Fujitsu.

Continuity of Specifications

There is no change to this datasheet as a result of offering the device as a Spansion product. Any changes that have been made are the result of normal datasheet improvement and are noted in the document revision summary, where supported. Future routine revisions will occur when appropriate, and changes will be noted in a revision summary.

Continuity of Ordering Part Numbers

AMD and Fujitsu continue to support existing part numbers beginning with "Am" and "MBM". To order these products, please use only the Ordering Part Numbers listed in this document.

For More Information

Please contact your local AMD or Fujitsu sales office for additional information about Spansion memory solutions.







Am29LV040B

4 Megabit (512 K x 8-Bit) CMOS 3.0 Volt-only, Uniform Sector 32-Pin Flash Memory

DISTINCTIVE CHARACTERISTICS

■ Single power supply operation

- Full voltage range: 2.7 to 3.6 volt read and write operations for battery-powered applications
- Regulated voltage range: 3.0 to 3.6 volt read and write operations and for compatibility with high performance 3.3 volt microprocessors

■ Manufactured on 0.32 µm process technology

■ High performance

- Full voltage range: access times as fast as 70 ns
- Regulated voltage range: access times as fast as 60 ns

Ultra low power consumption (typical values at 5 MHz)

Automatic sleep mode: 0.2 μA

Standby mode: 0.2 μARead mode: 7 mA

— Program/erase mode: 15 mA

■ Flexible sector architecture

- Eight 64 Kbyte sectors
- Any combination of sectors can be erased; supports full chip erase
- Sector Protection features:

Hardware method of locking a sector to prevent any program or erase operations within that sector Sectors can be locked via programming equipment

■ Unlock Bypass Program Command

Reduces overall programming time when issuing multiple program command sequences

■ Embedded Algorithms

- Embedded Erase algorithms automatically preprogram and erase the entire chip or any combination of designated sectors
- Embedded Program algorithms automatically writes and verifies data at specified addresses

■ Minimum 1,000,000 erase cycles guaranteed

■ 20-year data retention at 125°C

Reliable operation for the life of the system

■ Package option

- 32-pin PLCC
- 32-pin TSOP

■ Compatibility with JEDEC standards

- Pinout and software compatible with singlepower supply Flash
- Superior inadvertent write protection

■ Data# Polling and toggle bits

 Provides a software method of detecting program or erase cycle completion

■ Erase Suspend/Resume

 Supports reading data from or programming data to a sector not being erased



GENERAL DESCRIPTION

The Am29LV040B is a single power supply, 4 Mbit, 3.0 Volt-only Flash memory device organized as 524,288 bytes. The data appears on DQ0-DQ7. The device is available in 32-pin PLCC and 32-pin TSOP packages. All read, erase, and program operations are accomplished using only a single power supply. The device can also be programmed in standard EPROM programmers.

The device offers access times of 60, 70, 90, and 120 ns allowing high speed microprocessors to operate without wait states. To eliminate bus contention, the device has separate control pins—chip enable (CE#), write enable (WE#), and output enable (OE#)—to control normal read and write operations.

The device requires only a **single power supply** (2.7 V–3.6V) for both read and write functions. Internally generated and regulated voltages are provided for the program and erase operations.

The device is entirely command set compatible with the **JEDEC single-power-supply Flash standard**. Commands are written to the command register using standard microprocessor write timings. Register contents serve as input to an internal state-machine that controls the erase and programming circuitry. Write cycles also internally latch addresses and data needed for the programming and erase operations. Reading data out of the device is similar to reading from other Flash or EPROM devices.

Device programming occurs by executing the program command sequence. This initiates the **Embedded Program** algorithm—an internal algorithm that automatically times the program pulse widths and verifies proper cell margin. The **Unlock Bypass** mode facilitates faster programming times by requiring only two write cycles to program data instead of four.

Device erasure occurs by executing the erase command sequence. This initiates the **Embedded Erase** algorithm—an internal algorithm that automatically

preprograms the array (if it is not already programmed) before executing the erase operation. During erase, the device automatically times the erase pulse widths and verifies proper cell margin.

The host system can detect whether a program or erase operation is complete by reading the DQ7 (Data# Polling) and DQ6 (toggle) **status bits**. After a program or erase cycle has been completed, the device is ready to read array data or accept another command.

The **sector erase architecture** allows memory sectors to be erased and reprogrammed without affecting the data contents of other sectors. The device is fully erased when shipped from the factory.

Hardware data protection measures include a low V_{CC} detector that automatically inhibits write operations during power transitions. The hardware sector protection feature disables both program and erase operations in any combination of the sectors of memory. This is achieved via programming equipment.

The **Erase Suspend** feature enables the user to put erase on hold for any period of time to read data from, or program data to, any sector that is not selected for erasure. True background erase can thus be achieved.

The device offers two power-saving features. When addresses have been stable for a specified amount of time, the device enters the **automatic sleep mode**. The system can also place the device into the **standby mode**. Power consumption is greatly reduced in both these modes.

AMD's Flash technology combines years of Flash memory manufacturing experience to produce the highest levels of quality, reliability and cost effectiveness. The device electrically erases all bits within a sector simultaneously via Fowler-Nordheim tunneling. The data is programmed using hot electron injection.



TABLE OF CONTENTS

Product Selector Guide	
Block Diagram	
Connection Diagrams	. 5
Pin Configuration	.6
Logic Symbol	6
Ordering Information	.7
Device Bus Operations	
Table 1. Am29LV040B Device Bus Operations	
Requirements for Reading Array Data	
Writing Commands/Command Sequences	
Program and Erase Operation Status	
Standby Mode	
Automatic Sleep Mode	
Output Disable Mode	
Table 2. Am29LV040BT Sector Address Table	
Autoselect Mode	
Table 3. Am29LV040B Autoselect Codes (High Voltage Method)	10
Sector Protection/Unprotection	
Hardware Data Protection	
Low V _{CC} Write Inhibit	
Write Pulse "Glitch" Protection	10
Logical Inhibit	
Power-Up Write Inhibit	
Command Definitions	11
Reading Array Data	. 11
Reset Command	
Autoselect Command Sequence	
Byte Program Command Sequence	
Unlock Bypass Command Sequence	
Chip Erase Command Sequence	
Figure 1. Program Operation	
Sector Erase Command Sequence	. 13
Erase Suspend/Erase Resume Commands	. 13
Figure 2. Erase Operation	
Command Definitions	. 15
Table 4. Am29LV040B Command Definitions	
Write Operation Status	
DQ7: Data# Polling	
Figure 3. Data# Polling Algorithm	
DQ6: Toggle Bit I	
DQ2: Toggle Bit II	
Reading Toggle Bits DQ6/DQ2	
Figure 4. Toggle Bit Algorithm	
DOS: Exceeded Timing Limits	18

DQ3: Sector Erase Timer	. 18
Table 5. Write Operation Status	
Absolute Maximum Ratings	
Figure 5. Maximum Negative Overshoot Waveform	
Figure 6. Maximum Positive Overshoot Waveform	
Operating Ranges	
DC Characteristics	21
Figure 7. I _{CC1} Current vs. Time (Showing Active and Automatic	
Sleep Currents)	22
Figure 8. Typical I _{CC1} vs. Frequency	
Test Conditions	
Figure 9. Test Setup	
Table 6. Test Specifications	
Key to Switching Waveforms	
Figure 10. Input Waveforms and Measurement Levels	
AC Characteristics	
Read Operations	
Figure 11. Read Operations Timings	
Erase/Program Operations	
Figure 12. Program Operation TimingsFigure 13. Chip/Sector Erase Operation Timings	
Figure 14. Data# Polling Timings (During Embedded Algorithms).	
Figure 15. Toggle Bit Timings (During Embedded Algorithms)	
Figure 16. DQ2 vs. DQ6	
Alternate CE# Controlled Erase/Program Operations	
Figure 17. Alternate CE# Controlled Write Operation Timings	
Erase and Programming Performance	
Latchup Characteristics	
TSOP and SO Pin Capacitance	
Data Retention	
Physical Dimensions	
TS 032—32-Pin Standard TSOP	
TSR032—32-Pin Reverse TSOP	
PL 032—32-Pin Plastic Leaded Chip Carrier	
Revision Summary	
Revision A (January 1998)	
Revision B (April 1998)	
Revision B+1 (November 1998)	. 35
Revision C (January 1999)	
Revision C+1 (May 18, 1999)	
Revision C+2 (July 20, 1999)	
Revision D (November 11, 1999)	. 35
Revision D+1 (November 13, 2000)	
Revision F (March 12, 2003)	

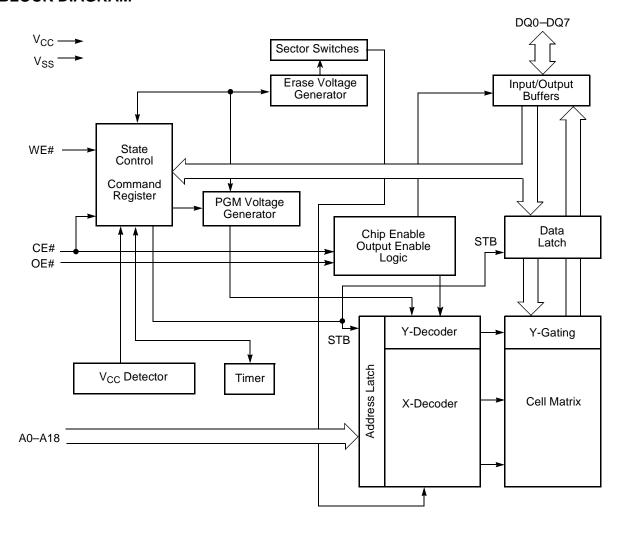


PRODUCT SELECTOR GUIDE

Family Part Num	Am29LV040B						
Speed Options	Regulated Voltage Range: V _{CC} =3.0–3.6 V	-60R					
Speed Options	Full Voltage Range: V _{CC} = 2.7–3.6 V		-70	-90	-120		
Max access time, ns (t _{ACC})		60	70	90	120		
Max CE# access time, ns (t _{CE})		60	70	90	120		
Max OE# access time, ns (t _{OE})		30	30	30	35		

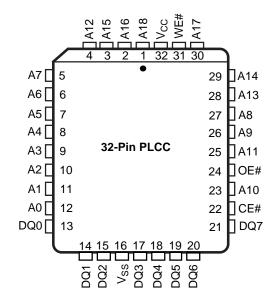
Note: See "AC Characteristics" for full specifications.

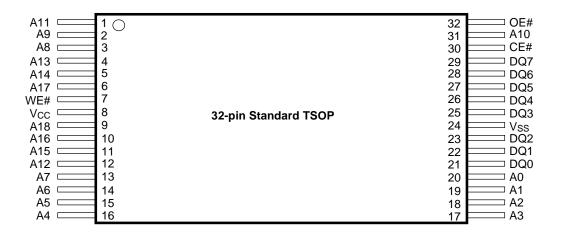
BLOCK DIAGRAM

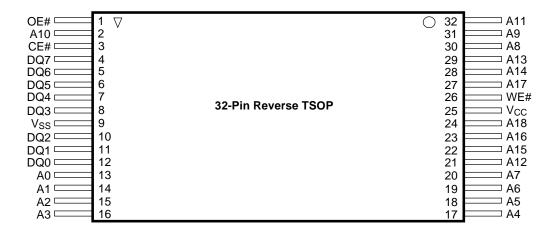




CONNECTION DIAGRAMS









PIN CONFIGURATION

A0-A18 = 19 address inputs

DQ0-DQ7 = 8 data inputs/outputs

CE# = Chip enable

OE# = Output enable

WE# = Write enable

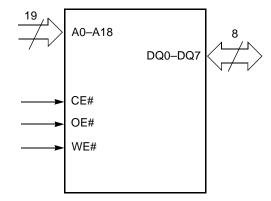
 V_{CC} = 3.0 volt-only single power supply

(see Product Selector Guide for speed

options and voltage supply tolerances)

 V_{SS} = Device ground

LOGIC SYMBOL

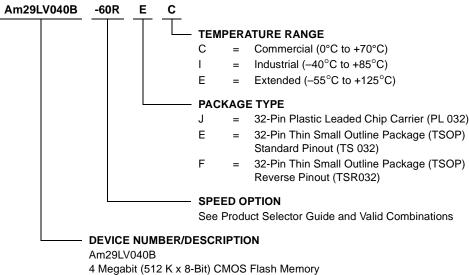




ORDERING INFORMATION

Standard Products

AMD standard products are available in several packages and operating ranges. The order number (Valid Combination) is formed by a combination of the elements below.



Am29LV040B
4 Megabit (512 K x 8-Bit) CMOS Flash Memor
3.0 Volt-only Read, Program and Erase

Valid Combinations									
AM29LV040B-60R	JC, JI, EC, EI, FC, FI								
AM29LV040B-70	JC, JI, JE,								
AM29LV040B-90	EC, EI, EE,								
AM29LV040B-120	FC, FI, FE								

Valid Combinations

Valid Combinations list configurations planned to be supported in volume for this device. Consult the local AMD sales office to confirm availability of specific valid combinations and to check on newly released combinations.



DEVICE BUS OPERATIONS

This section describes the requirements and use of the device bus operations, which are initiated through the internal command register. The command register itself does not occupy any addressable memory location. The register is composed of latches that store the commands, along with the address and data information needed to execute the command. The contents of the

register serve as inputs to the internal state machine. The state machine outputs dictate the function of the device. Table 1 lists the device bus operations, the inputs and control levels they require, and the resulting output. The following subsections describe each of these operations in further detail.

Operation	CE#	OE#	WE#	Addresses (Note 1)	DQ0-DQ7
Read	L	L	Н	A _{IN}	D _{OUT}
Write	L	Н	L	A _{IN}	D _{IN}
Standby	$V_{CC} \pm 0.3 V$	X	Х	X	High-Z
Output Disable	L	Н	Н	X	High-Z
Reset	Х	Х	Х	X	High-Z
Sector Protect (Note 2)	L	Н	L	Sector Address, A6 = L, A1 = H, A0 = L	D _{IN} , D _{OUT}
Sector Unprotect (Note 2)	L	Н	L	Sector Address, A6 = H, A1 = H, A0 = L	D _{IN} , D _{OUT}
Temporary Sector Unprotect	Х	Х	Х	A _{IN}	D _{IN}

Table 1. Am29LV040B Device Bus Operations

Legend:

 $L = Logic\ Low = V_{IL},\ H = Logic\ High = V_{IH},\ V_{ID} = 12.0\pm0.5\ V,\ X = Don't\ Care,\ A_{IN} = Address\ In,\ D_{IN} = Data\ In,\ D_{OUT} = Data\ Out$

Notes

- 1. Addresses are A18-A0.
- 2. The sector protect and sector unprotect functions may also be implemented via programming equipment. See the "Sector Protection/Unprotection" section.

Requirements for Reading Array Data

To read array data from the outputs, the system must drive the CE# and OE# pins to V_{IL} . CE# is the power control and selects the device. OE# is the output control and gates array data to the output pins. WE# should remain at V_{IH} .

The internal state machine is set for reading array data upon device power-up, or after a hardware reset. This ensures that no spurious alteration of the memory content occurs during the power transition. No command is necessary in this mode to obtain array data. Standard microprocessor read cycles that assert valid addresses on the device address inputs produce valid data on the device data outputs. The device remains enabled for read access until the command register contents are altered.

See "Reading Array Data" for more information. Refer to the AC Read Operations table for timing specifications and to Figure 11 for the timing diagram. I_{CC1} in the DC Characteristics table represents the active current specification for reading array data.

Writing Commands/Command Sequences

To write a command or command sequence (which includes programming data to the device and erasing sectors of memory), the system must drive WE# and CE# to V_{IL} , and OE# to V_{IH} .

The device features an **Unlock Bypass** mode to facilitate faster programming. Once the device enters the Unlock Bypass mode, only two write cycles are required to program a byte, instead of four. The "Byte Program Command Sequence" section has details on programming data to the device using both standard and Unlock Bypass command sequences.

An erase operation can erase one sector, multiple sectors, or the entire device. Table 2 indicates the address space that each sector occupies. A "sector address" consists of the address bits required to uniquely select a sector. The "Command Definitions" section has details on erasing a sector or the entire chip, or suspending/resuming the erase operation.

After the system writes the autoselect command sequence, the device enters the autoselect mode. The system can then read autoselect codes from the internal register (which is separate from the memory array) on DQ7–DQ0. Standard read cycle timings



apply in this mode. Refer to the Autoselect Mode and Autoselect Command Sequence sections for more information.

I_{CC2} in the DC Characteristics table represents the active current specification for the write mode. The "AC Characteristics" section contains timing specification tables and timing diagrams for write operations.

Program and Erase Operation Status

During an erase or program operation, the system may check the status of the operation by reading the status bits on DQ7–DQ0. Standard read cycle timings and I_{CC} read specifications apply. Refer to "Write Operation Status" for more information, and to "AC Characteristics" for timing diagrams.

Standby Mode

When the system is not reading or writing to the device, it can place the device in the standby mode. In this mode, current consumption is greatly reduced, and the outputs are placed in the high impedance state, independent of the OE# input.

The device enters the CMOS standby mode when the CE# pin is both held at $V_{CC}\pm0.3$ V. (Note that this is a more restricted voltage range than V_{IH} .) If CE# is held at V_{IH} , but not within $V_{CC}\pm0.3$ V, the device will be in

the standby mode, but the standby current will be greater. The device requires standard access time (t_{CE}) for read access when the device is in either of these standby modes, before it is ready to read data.

If the device is deselected during erasure or programming, the device draws active current until the operation is completed.

I_{CC3} in the DC Characteristics table represents the standby current specification.

Automatic Sleep Mode

The automatic sleep mode minimizes Flash device energy consumption. The device automatically enables this mode when addresses remain stable for $t_{ACC} + 30$ ns. The automatic sleep mode is independent of the CE#, WE#, and OE# control signals. Standard address access timings provide new data when addresses are changed. While in sleep mode, output data is latched and always available to the system. I_{CC4} in the DC Characteristics table represents the automatic sleep mode current specification.

Output Disable Mode

When the OE# input is at V_{IH} , output from the device is disabled. The output pins are placed in the high impedance state.

Sector	A18	A17	A16	Address Range (in hexadecimal)
SA0	0	0	0	00000h-0FFFFh
SA1	0	0	1	10000h-1FFFFh
SA2	0	1	0	20000h-2FFFFh
SA3	0	1	1	30000h-3FFFFh
SA4	1	0	0	40000h-4FFFFh
SA5	1	0	1	50000h-5FFFFh
SA6	1	1	0	60000h-6FFFFh
SA7	1	1	1	70000h-7FFFFh

Table 2. Am29LV040BT Sector Address Table

Autoselect Mode

The autoselect mode provides manufacturer and device identification, and sector protection verification, through identifier codes output on DQ7–DQ0. This mode is primarily intended for programming equipment to automatically match a device to be programmed with its corresponding programming algorithm. However, the autoselect codes can also be accessed in-system through the command register.

When using programming equipment, the autoselect mode requires V_{ID} (11.5 V to 12.5 V) on address pin A9. Address pins A6, A1, and A0 must be as shown in

Table 3. In addition, when verifying sector protection, the sector address must appear on the appropriate highest order address bits (see Table 2). Table 3 shows the remaining address bits that are don't care. When all necessary bits have been set as required, the programming equipment may then read the corresponding identifier code on DQ7–DQ0.

To access the autoselect codes in-system, the host system can issue the autoselect command via the command register, as shown in Table 4. This method does not require V_{ID} . See "Command Definitions" for details on using the autoselect mode.



Table 3. Am29LV040B Autoselect Codes (High Voltage Method)

Description	CE#	OE#	WE#	A18 to A16	A15 to A10	A9	A8 to A7	A6	A5 to A2	A 1	A0	DQ7 to DQ0
Manufacturer ID: AMD	L	L	Н	Х	Х	V_{ID}	Х	L	Х	L	L	01h
Device ID: Am29LV040B	L	L	Н	Х	Х	V_{ID}	Χ	L	Х	L	Н	4Fh
Sector Protection Verification			Ш	SΛ	V	V	V			Ш		01h (protected)
Sector Protection Vernication	L	L	Н	H SA	SA X	V _{ID}	X	L	Х	Н	L	00h (unprotected)

 $L = Logic Low = V_{IL}$, $H = Logic High = V_{IH}$, SA = Sector Address, X = Don't care.

Sector Protection/Unprotection

The hardware sector protection feature disables both program and erase operations in any sector. The hardware sector unprotection feature re-enables both program and erase operations in previously protected sectors.

Sector protection/unprotection method intended only for programming equipment requires $V_{\rm ID}$ on address pin A9 and OE#. This method is compatible with programmer routines written for earlier 3.0 volt-only AMD flash devices. Publication number 22168 contains further details; contact an AMD representative to request a copy.

The device is shipped with all sectors unprotected. AMD offers the option of programming and protecting sectors at its factory prior to shipping the device through AMD's ExpressFlash™ Service. Contact an AMD representative for details.

It is possible to determine whether a sector is protected or unprotected. See "Autoselect Mode" for details.

Hardware Data Protection

The command sequence requirement of unlock cycles for programming or erasing provides data protection against inadvertent writes (refer to Table 4 for command definitions). In addition, the following hardware data protection measures prevent accidental

erasure or programming, which might otherwise be caused by spurious system level signals during V_{CC} power-up and power-down transitions, or from system noise.

Low V_{CC} Write Inhibit

When V_{CC} is less than V_{LKO} , the device does not accept any write cycles. This protects data during V_{CC} power-up and power-down. The command register and all internal program/erase circuits are disabled, and the device resets. Subsequent writes are ignored until V_{CC} is greater than V_{LKO} . The system must provide the proper signals to the control pins to prevent unintentional writes when V_{CC} is greater than V_{LKO} .

Write Pulse "Glitch" Protection

Noise pulses of less than 5 ns (typical) on OE#, CE# or WE# do not initiate a write cycle.

Logical Inhibit

Write cycles are inhibited by holding any one of OE# = V_{IL} , CE# = V_{IH} or WE# = V_{IH} . To initiate a write cycle, CE# and WE# must be a logical zero while OE# is a logical one.

Power-Up Write Inhibit

If WE# = CE# = V_{IL} and OE# = V_{IH} during power up, the device does not accept commands on the rising edge of WE#. The internal state machine is automatically reset to reading array data on power-up.



COMMAND DEFINITIONS

Writing specific address and data commands or sequences into the command register initiates device operations. Table 4 defines the valid register command sequences. Writing incorrect address and data values or writing them in the improper sequence may place the device in an unknown state. A reset command is then required to return the device to reading array data.

All addresses are latched on the falling edge of WE# or CE#, whichever happens later. All data is latched on the rising edge of WE# or CE#, whichever happens first. Refer to the appropriate timing diagrams in the "AC Characteristics" section.

Reading Array Data

The device is automatically set to reading array data after device power-up. No commands are required to retrieve data. The device is also ready to read array data after completing an Embedded Program or Embedded Erase algorithm.

After the device accepts an Erase Suspend command, the device enters the Erase Suspend mode. The system can read array data using the standard read timings, except that if it reads at an address within erase-suspended sectors, the device outputs status data. After completing a programming operation in the Erase Suspend mode, the system may once again read array data with the same exception. See "Erase Suspend/Erase Resume Commands" for more information on this mode.

The system *must* issue the reset command to reenable the device for reading array data if DQ5 goes high, or while in the autoselect mode. See the "Reset Command" section, next.

See also "Requirements for Reading Array Data" in the "Device Bus Operations" section for more information. The Read Operations table provides the read parameters, and Figure 11 shows the timing diagram.

Reset Command

Writing the reset command to the device resets the device to reading array data. Address bits are don't care for this command.

The reset command may be written between the sequence cycles in an erase command sequence before erasing begins. This resets the device to reading array data. Once erasure begins, however, the device ignores reset commands until the operation is complete.

The reset command may be written between the sequence cycles in a program command sequence before programming begins. This resets the device to reading array data (also applies to programming in Erase Suspend mode). Once programming begins,

however, the device ignores reset commands until the operation is complete.

The reset command may be written between the sequence cycles in an autoselect command sequence. Once in the autoselect mode, the reset command *must* be written to return to reading array data (also applies to autoselect during Erase Suspend).

If DQ5 goes high during a program or erase operation, writing the reset command returns the device to reading array data (also applies during Erase Suspend).

Autoselect Command Sequence

The autoselect command sequence allows the host system to access the manufacturer and devices codes, and determine whether or not a sector is protected. Table 4 shows the address and data requirements. This method is an alternative to that shown in Table 3, which is intended for PROM programmers and requires V_{ID} on address bit A9.

The autoselect command sequence is initiated by writing two unlock cycles, followed by the autoselect command. The device then enters the autoselect mode, and the system may read at any address any number of times, without initiating another command sequence. A read cycle at address 00h retrieves the manufacturer code. A read cycle at address 01h returns the device code. A read cycle containing a sector address (SA) and the address 02h returns 01h if that sector is protected, or 00h if it is unprotected. Refer to Table 2 for valid sector addresses.

The system must write the reset command to exit the autoselect mode and return to reading array data.

Byte Program Command Sequence

The byte program command sequence programs one byte into the device. Programming is a four-bus-cycle operation. The program command sequence is initiated by writing two unlock write cycles, followed by the program set-up command. The program address and data are written next, which in turn initiate the Embedded Program algorithm. The system is *not* required to provide further controls or timings. The device automatically provides internally generated program pulses and verify the programmed cell margin. Table 4 shows the address and data requirements for the byte program command sequence. *Note that the autoselect function is unavailable when a program operation is in progress*.

When the Embedded Program algorithm is complete, the device then returns to reading array data and addresses are no longer latched. The system can determine the status of the program operation by using



DQ7 or DQ6. See "Write Operation Status" for information on these status bits.

Any commands written to the device during the Embedded Program Algorithm are ignored. Note that a hardware reset immediately terminates the programming operation. The Byte Program command sequence should be reinitiated once the device has reset to reading array data, to ensure data integrity.

Programming is allowed in any sequence and across sector boundaries. A bit cannot be programmed from a "0" back to a "1". Attempting to do so may halt the operation and set DQ5 to "1", or cause the Data# Polling algorithm to indicate the operation was successful. However, a succeeding read will show that the data is still "0". Only erase operations can convert a "0" to a "1".

Unlock Bypass Command Sequence

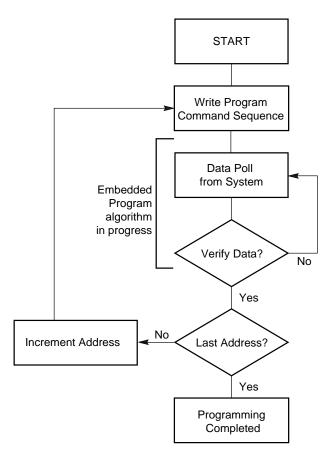
The unlock bypass feature allows the system to program bytes to the device faster than using the standard program command sequence. The unlock bypass command sequence is initiated by first writing two unlock cycles. This is followed by a third write cycle containing the unlock bypass command, 20h. The device then enters the unlock bypass mode. A twocycle unlock bypass program command sequence is all that is required to program in this mode. The first cycle in this sequence contains the unlock bypass program command, A0h; the second cycle contains the program address and data. Additional data is programmed in the same manner. This mode dispenses with the initial two unlock cycles required in the standard program command sequence, resulting in faster total programming time. Table 4 shows the requirements for the command sequence.

During the unlock bypass mode, only the Unlock Bypass Program and Unlock Bypass Reset commands are valid. To exit the unlock bypass mode, the system must issue the two-cycle unlock bypass reset command sequence. The first cycle must contain the data 90h; the second cycle the data 00h. The device then returns to reading array data.

Figure 1 illustrates the algorithm for the program operation. See the Erase/Program Operations table in "AC Characteristics" for parameters, and to Figure 12 for timing diagrams.

Chip Erase Command Sequence

Chip erase is a six bus cycle operation. The chip erase command sequence is initiated by writing two unlock cycles, followed by a set-up command. Two additional unlock write cycles are then followed by the chip erase command, which in turn invokes the Embedded Erase algorithm. The device does *not* require the system to preprogram prior to erase. The Embedded Erase algorithm automatically preprograms and verifies the entire



Note: See Table 4 for program command sequence.

Figure 1. Program Operation

memory for an all zero data pattern prior to electrical erase. The system is not required to provide any controls or timings during these operations. Table 4 shows the address and data requirements for the chip erase command sequence. Note that the autoselect function is unavailable when an erase operation is in progress.

Any commands written to the chip during the Embedded Erase algorithm are ignored. Note that a hardware reset during the chip erase operation immediately terminates the operation. The Chip Erase command sequence should be reinitiated once the device has returned to reading array data, to ensure data integrity.

The system can determine the status of the erase operation by using DQ7, DQ6, or DQ2. See "Write Operation Status" for information on these status bits. When the Embedded Erase algorithm is complete, the device returns to reading array data and addresses are no longer latched.

Figure 2 illustrates the algorithm for the erase operation. See the Erase/Program Operations tables in "AC



Characteristics" for parameters, and to Figure 13 for timing diagrams.

Sector Erase Command Sequence

Sector erase is a six bus cycle operation. The sector erase command sequence is initiated by writing two unlock cycles, followed by a set-up command. Two additional unlock write cycles are then followed by the address of the sector to be erased, and the sector erase command. Table 4 shows the address and data requirements for the sector erase command sequence. Note that the autoselect function is unavailable when an erase operation is in progress.

The device does *not* require the system to preprogram the memory prior to erase. The Embedded Erase algorithm automatically programs and verifies the sector for an all zero data pattern prior to electrical erase. The system is not required to provide any controls or timings during these operations.

After the command sequence is written, a sector erase time-out of 50 µs begins. During the time-out period, additional sector addresses and sector erase commands may be written. Loading the sector erase buffer may be done in any sequence, and the number of sectors may be from one sector to all sectors. The time between these additional cycles must be less than 50 µs, otherwise the last address and command might not be accepted, and erasure may begin. It is recommended that processor interrupts be disabled during this time to ensure all commands are accepted. The interrupts can be re-enabled after the last Sector Erase command is written. If the time between additional sector erase commands can be assumed to be less than 50 µs, the system need not monitor DQ3. Any command other than Sector Erase or Erase Suspend during the time-out period resets the device to reading array data. The system must rewrite the command sequence and any additional sector addresses and commands.

The system can monitor DQ3 to determine if the sector erase timer has timed out. (See the "DQ3: Sector Erase Timer" section.) The time-out begins from the rising edge of the final WE# pulse in the command sequence.

Once the sector erase operation has begun, only the Erase Suspend command is valid. All other commands are ignored. Note that a **hardware reset** during the sector erase operation immediately terminates the operation. The Sector Erase command sequence should be reinitiated once the device has returned to reading array data, to ensure data integrity.

When the Embedded Erase algorithm is complete, the device returns to reading array data and addresses are

no longer latched. The system can determine the status of the erase operation by using DQ7, DQ6, or DQ2. (Refer to "Write Operation Status" for information on these status bits.)

Figure 2 illustrates the algorithm for the erase operation. Refer to the Erase/Program Operations tables in the "AC Characteristics" section for parameters, and to Figure 13 for timing diagrams.

Erase Suspend/Erase Resume Commands

The Erase Suspend command allows the system to interrupt a sector erase operation and then read data from, or program data to, any sector not selected for erasure. This command is valid only during the sector erase operation, including the 50 µs time-out period during the sector erase command sequence. The Erase Suspend command is ignored if written during the chip erase operation or Embedded Program algorithm. Writing the Erase Suspend command during the Sector Erase time-out immediately terminates the time-out period and suspends the erase operation. Addresses are "don't-cares" when writing the Erase Suspend command.

When the Erase Suspend command is written during a sector erase operation, the device requires a maximum of 20 µs to suspend the erase operation. However, when the Erase Suspend command is written during the sector erase time-out, the device immediately terminates the time-out period and suspends the erase operation.

After the erase operation has been suspended, the system can read array data from or program data to any sector not selected for erasure. (The device "erase suspends" all sectors selected for erasure.) Normal read and write timings and command definitions apply. Reading at any address within erase-suspended sectors produces status data on DQ7–DQ0. The system can use DQ7, or DQ6 and DQ2 together, to determine if a sector is actively erasing or is erase-suspended. See "Write Operation Status" for information on these status bits.

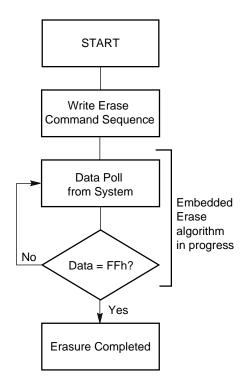
After an erase-suspended program operation is complete, the system can once again read array data within non-suspended sectors. The system can determine the status of the program operation using the DQ7 or DQ6 status bits, just as in the standard program operation. See "Write Operation Status" for more information.

The system may also write the autoselect command sequence when the device is in the Erase Suspend mode. The device allows reading autoselect codes even at addresses within erasing sectors, since the codes are not stored in the memory array. When the



device exits the autoselect mode, the device reverts to the Erase Suspend mode, and is ready for another valid operation. See "Autoselect Command Sequence" for more information.

The system must write the Erase Resume command (address bits are "don't care") to exit the erase suspend mode and continue the sector erase operation. Further writes of the Resume command are ignored. Another Erase Suspend command can be written after the device has resumed erasing.



- 1. See Table 4 for erase command sequence.
- 2. See "DQ3: Sector Erase Timer" for more information.

Figure 2. Erase Operation



Command Definitions

Table 4. Am29LV040B Command Definitions

		Bus Cycles (Notes 2-4)												
Command Sequence		Cycles	Fir	st	Second		Third		Fourth		Fifth		Sixth	
	(Note 1)		Addr	Data	Addr	Data	Addr	Data	Addr	Data	Addr	Data	Addr	Data
Read (N	lote 5)	1	RA	RD										
Reset (N	Note 6)	1	XXX	F0										
Auto- select (Note 7)	Manufacturer ID	4	555	AA	2AA	55	555	90	X00	01				
	Device ID	4	555	AA	2AA	55	555	90	X01	4F				
	Sector Protect Verify	4	555	AA	2AA	55	555	90	(SA)	00				
(**************************************	(Note 8)	4	333	AA	ZAA			90	X02	01				
Program	1	4	555	AA	2AA	55	555	A0	PA	PD				
Unlock E	Bypass	3	555	AA	2AA	55	555	20						
Unlock E	Bypass Program (Note 9)	2	XXX	A0	PA	PD								
Unlock E	Bypass Reset (Note 10)	2	XXX	90	XXX	00								
Chip Era	ase	6	555	AA	2AA	55	555	80	555	AA	2AA	55	555	10
Sector E	rase	6	555	AA	2AA	55	555	80	555	AA	2AA	55	SA	30
Erase Suspend (Note 11)		1	XXX	В0										
Erase R	esume (Note 12)	1	XXX	30										

Legend:

X = Don't care

RA = Address of the memory location to be read.

RD = Data read from location RA during read operation.

PA = Address of the memory location to be programmed. Addresses latch on the falling edge of the WE# or CE# pulse, whichever happens later. PD = Data to be programmed at location PA. Data latches on the rising edge of WE# or CE# pulse, whichever happens first.

SA = Address of the sector to be verified (in autoselect mode) or erased. Address bits A18–A13 uniquely select any sector.

- 1. See Table 1 for description of bus operations.
- 2. All values are in hexadecimal.
- Except when reading array or autoselect data, all command bus cycles are write operations.
- Address bits A18–A11 are don't cares for unlock and command cycles.
- No unlock or command cycles required when reading array data.
- The Reset command is required to return to reading array data when device is in the autoselect mode, or if DQ5 goes high (while the device is providing status data).
- 7. The fourth cycle of the autoselect command sequence is a read cycle.
- The data is 00h for an unprotected sector and 01h for a protected sector. See "Autoselect Command Sequence" for more information.

- The Unlock Bypass command is required prior to the Unlock Bypass Program command.
- The Unlock Bypass Reset command is required to return to reading array data when the device is in the unlock bypass mode
- 11. The system may read and program in non-erasing sectors, or enter the autoselect mode, when in the Erase Suspend mode. The Erase Suspend command is valid only during a sector erase operation.
- The Erase Resume command is valid only during the Erase Suspend mode.



WRITE OPERATION STATUS

The device provides several bits to determine the status of a write operation: DQ2, DQ3, DQ5, DQ6, and DQ7. Table 5 and the following subsections describe the functions of these bits. DQ7 and DQ6 each offer a method for determining whether a program or erase operation is complete or in progress. These three bits are discussed first.

DQ7: Data# Polling

The Data# Polling bit, DQ7, indicates to the host system whether an Embedded Algorithm is in progress or completed, or whether the device is in Erase Suspend. Data# Polling is valid after the rising edge of the final WE# pulse in the program or erase command sequence.

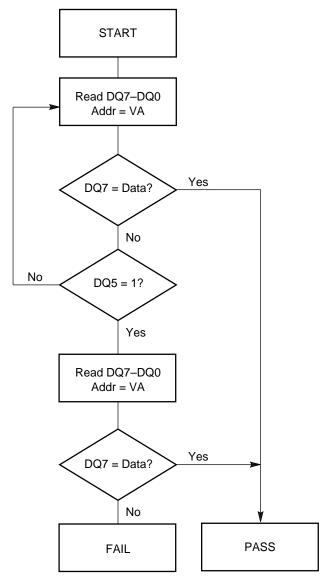
During the Embedded Program algorithm, the device outputs on DQ7 the complement of the datum programmed to DQ7. This DQ7 status also applies to programming during Erase Suspend. When the Embedded Program algorithm is complete, the device outputs the datum programmed to DQ7. The system must provide the program address to read valid status information on DQ7. If a program address falls within a protected sector, Data# Polling on DQ7 is active for approximately 1 μ s, then the device returns to reading array data.

During the Embedded Erase algorithm, Data# Polling produces a "0" on DQ7. When the Embedded Erase algorithm is complete, or if the device enters the Erase Suspend mode, Data# Polling produces a "1" on DQ7. This is analogous to the complement/true datum output described for the Embedded Program algorithm: the erase function changes all the bits in a sector to "1"; prior to this, the device outputs the "complement," or "0." The system must provide an address within any of the sectors selected for erasure to read valid status information on DQ7.

After an erase command sequence is written, if all sectors selected for erasing are protected, Data# Polling on DQ7 is active for approximately 100 μs , then the device returns to reading array data. If not all selected sectors are protected, the Embedded Erase algorithm erases the unprotected sectors, and ignores the selected sectors that are protected.

When the system detects DQ7 has changed from the complement to true data, it can read valid data at DQ7–DQ0 on the *following* read cycles. This is because DQ7 may change asynchronously with DQ0–DQ6 while Output Enable (OE#) is asserted low. Figure 14, Data#Polling Timings (During Embedded Algorithms), in the "AC Characteristics" section illustrates this.

Table 5 shows the outputs for Data# Polling on DQ7. Figure 3 shows the Data# Polling algorithm.



- VA = Valid address for programming. During a sector erase operation, a valid address is an address within any sector selected for erasure. During chip erase, a valid address is any non-protected sector address.
- DQ7 should be rechecked even if DQ5 = "1" because DQ7 may change simultaneously with DQ5.

Figure 3. Data# Polling Algorithm



DQ6: Toggle Bit I

Toggle Bit I on DQ6 indicates whether an Embedded Program or Erase algorithm is in progress or complete, or whether the device has entered the Erase Suspend mode. Toggle Bit I may be read at any address, and is valid after the rising edge of the final WE# pulse in the command sequence (prior to the program or erase operation), and during the sector erase time-out.

During an Embedded Program or Erase algorithm operation, successive read cycles to any address cause DQ6 to toggle. The system may use either OE# or CE# to control the read cycles. When the operation is complete, DQ6 stops toggling.

After an erase command sequence is written, if all sectors selected for erasing are protected, DQ6 toggles for approximately 100 μ s, then returns to reading array data. If not all selected sectors are protected, the Embedded Erase algorithm erases the unprotected sectors, and ignores the selected sectors that are protected.

The system can use DQ6 and DQ2 together to determine whether a sector is actively erasing or is erase-suspended. When the device is actively erasing (that is, the Embedded Erase algorithm is in progress), DQ6 toggles. When the device enters the Erase Suspend mode, DQ6 stops toggling. However, the system must also use DQ2 to determine which sectors are erasing or erase-suspended. Alternatively, the system can use DQ7 (see the subsection on DQ7: Data# Polling).

If a program address falls within a protected sector, DQ6 toggles for approximately 2 μ s after the program command sequence is written, then returns to reading array data.

DQ6 also toggles during the erase-suspend-program mode, and stops toggling once the Embedded Program algorithm is complete.

Table 5 shows the outputs for Toggle Bit I on DQ6. Figure 4 shows the toggle bit algorithm. Figure 15 in the "AC Characteristics" section shows the toggle bit timing diagrams. Figure 16 shows the differences between DQ2 and DQ6 in graphical form. See also the subsection on DQ2: Toggle Bit II.

DQ2: Toggle Bit II

The "Toggle Bit II" on DQ2, when used with DQ6, indicates whether a particular sector is actively erasing (that is, the Embedded Erase algorithm is in progress), or whether that sector is erase-suspended. Toggle Bit II is valid after the rising edge of the final WE# pulse in the command sequence.

DQ2 toggles when the system reads at addresses within those sectors that have been selected for erasure. (The system may use either OE# or CE# to control the read cycles.) But DQ2 cannot distinguish whether the sector is actively erasing or is erase-suspended. DQ6, by comparison, indicates whether the device is actively erasing, or is in Erase Suspend, but cannot distinguish which sectors are selected for erasure. Thus, both status bits are required for sector and mode information. Refer to Table 5 to compare outputs for DQ2 and DQ6.

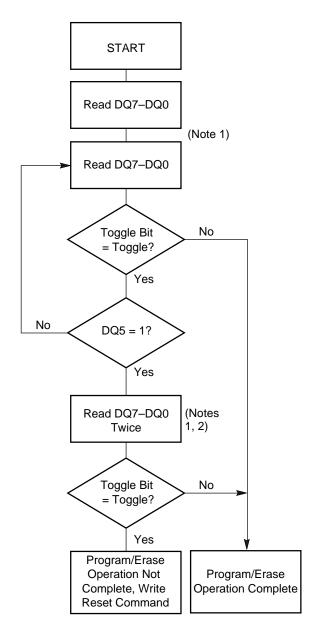
Figure 4 shows the toggle bit algorithm in flowchart form, and the section "DQ2: Toggle Bit II" explains the algorithm. See also the DQ6: Toggle Bit I subsection. Figure 15 shows the toggle bit timing diagram. Figure 16 shows the differences between DQ2 and DQ6 in graphical form.

Reading Toggle Bits DQ6/DQ2

Refer to Figure 4 for the following discussion. Whenever the system initially begins reading toggle bit status, it must read DQ7–DQ0 at least twice in a row to determine whether a toggle bit is toggling. Typically, the system would note and store the value of the toggle bit after the first read. After the second read, the system would compare the new value of the toggle bit with the first. If the toggle bit is not toggling, the device has completed the program or erase operation. The system can read array data on DQ7–DQ0 on the following read cycle.

However, if after the initial two read cycles, the system determines that the toggle bit is still toggling, the system also should note whether the value of DQ5 is high (see the section on DQ5). If it is, the system should then determine again whether the toggle bit is toggling, since the toggle bit may have stopped toggling just as DQ5 went high. If the toggle bit is no longer toggling, the device has successfully completed the program or erase operation. If it is still toggling, the device did not completed the operation successfully, and the system must write the reset command to return to reading array data.

The remaining scenario is that the system initially determines that the toggle bit is toggling and DQ5 has not gone high. The system may continue to monitor the toggle bit and DQ5 through successive read cycles, determining the status as described in the previous paragraph. Alternatively, it may choose to perform other system tasks. In this case, the system must start at the beginning of the algorithm when it returns to determine the status of the operation (top of Figure 4).



Notes:

- Read toggle bit twice to determine whether or not it is toggling. See text.
- 2. Recheck toggle bit because it may stop toggling as DQ5 changes to "1". See text.

Figure 4. Toggle Bit Algorithm

DQ5: Exceeded Timing Limits

DQ5 indicates whether the program or erase time has exceeded a specified internal pulse count limit. Under these conditions DQ5 produces a "1." This is a failure condition that indicates the program or erase cycle was not successfully completed.

The DQ5 failure condition may appear if the system tries to program a "1" to a location that is previously programmed to "0." **Only an erase operation can change a "0" back to a "1."** Under this condition, the device halts the operation, and when the operation has exceeded the timing limits, DQ5 produces a "1."

Under both these conditions, the system must issue the reset command to return the device to reading array data.

DQ3: Sector Erase Timer

After writing a sector erase command sequence, the system may read DQ3 to determine whether or not an erase operation has begun. (The sector erase timer does not apply to the chip erase command.) If additional sectors are selected for erasure, the entire timeout also applies after each additional sector erase command. When the time-out is complete, DQ3 switches from "0" to "1." If the time between additional sector erase commands from the system can be assumed to be less than 50 µs, the system need not monitor DQ3. See also the "Sector Erase Command Sequence" section.

After the sector erase command sequence is written, the system should read the status on DQ7 (Data# Polling) or DQ6 (Toggle Bit I) to ensure the device has accepted the command sequence, and then read DQ3. If DQ3 is "1", the internally controlled erase cycle has begun; all further commands (other than Erase Suspend) are ignored until the erase operation is complete. If DQ3 is "0", the device will accept additional sector erase commands. To ensure the command has been accepted, the system software should check the status of DQ3 prior to and following each subsequent sector erase command. If DQ3 is high on the second status check, the last command might not have been accepted. Table 5 shows the outputs for DQ3.



Table 5. Write Operation Status

	Operation	DQ7 (Note 2)	DQ6	DQ5 (Note 1)	DQ3	DQ2 (Note 2)
Standard	Embedded Program Algorithm	DQ7#	Toggle	0	N/A	No toggle
Mode	Embedded Erase Algorithm	0	Toggle	0	1	Toggle
Erase	Reading within Erase Suspended Sector	1	No toggle	0	N/A	Toggle
Suspend Mode	Reading within Non-Erase Suspended Sector	Data	Data	Data	Data	Data
	Erase-Suspend-Program	DQ7#	Toggle	0	N/A	N/A

Notes:

2. DQ7 and DQ2 require a valid address when reading status information. Refer to the appropriate subsection for further details.

^{1.} DQ5 switches to '1' when an Embedded Program or Embedded Erase operation has exceeded the maximum timing limits. See "" for more information.

ABSOLUTE MAXIMUM RATINGS

Storage Temperature Plastic Packages65°C to +150°C
Ambient Temperature with Power Applied65°C to +125°C
Voltage with Respect to Ground
V _{CC} (Note 1)0.5 V to +4.0 V
A9, OE# (Note 2)0.5 V to +12.5 V
All other pins
(Note 1)
Output Short Circuit Current (Note 3) 200 mA
Notes:

Minimum DC voltage on input or I/O pins is -0.5 V. During voltage transitions, input or I/O pins may overshoot V_{SS} to -2.0 V for periods of up to 20 ns. See Figure 5. Maximum DC voltage on input or I/O pins is V_{CC} +0.5 V. During voltage transitions, input or I/O pins may overshoot to V_{CC} +2.0 V for periods up to 20 ns. See Figure 6.

- 2. Minimum DC input voltage on pins A9 and OE# is -0.5 V. During voltage transitions, A9 and OE# may overshoot V_{SS} to -2.0 V for periods of up to 20 ns. See Figure 5. Maximum DC input voltage on pin A9 is +12.5 V which may overshoot to 14.0 V for periods up to 20 ns.
- No more than one output may be shorted to ground at a time. Duration of the short circuit should not be greater than one second.

Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational sections of this data sheet is not implied. Exposure of the device to absolute maximum rating conditions for extended periods may affect device reliability.

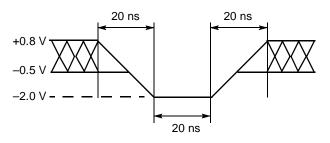


Figure 5. Maximum Negative Overshoot Waveform

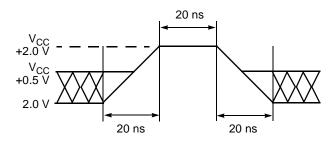


Figure 6. Maximum Positive Overshoot Waveform

OPERATING RANGES

Commercial (C) Devices

Ambient Temperature (T_A) 0°C to +70°C

Industrial (I) Devices

Ambient Temperature (T_A) -40°C to +85°C

Extended (E) Devices

Ambient Temperature (T_A) -55°C to +125°C

V_{CC} Supply Voltages

V_{CC} for regulated voltage range. 3.0 V to 3.6 V

V_{CC} for full voltage range 2.7 V to 3.6 V

Operating ranges define those limits between which the functionality of the device is guaranteed.



DC CHARACTERISTICS CMOS Compatible

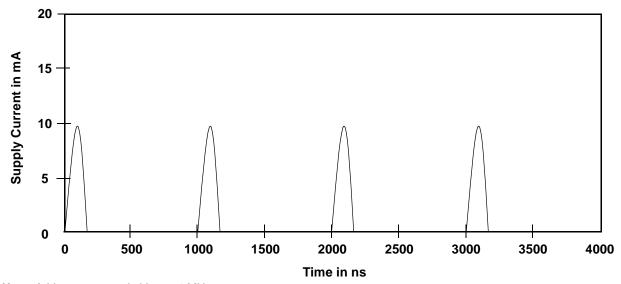
Parameter	Description	Test Condition	s	Min	Тур	Max	Unit
ILI	Input Load Current	$V_{IN} = V_{SS}$ to V_{CC} , $V_{CC} = V_{CC \text{ max}}$				±1.0	μA
I _{LIT}	A9 Input Load Current	$V_{CC} = V_{CC \text{ max}}; A9 = 12$.5 V			35	μA
I _{LO}	Output Leakage Current	$V_{OUT} = V_{SS}$ to V_{CC} , $V_{CC} = V_{CC \text{ max}}$				±1.0	μA
	V _{CC} Active Read Current	OF# \/ OF# \/	5 MHz		7	12	A
I _{CC1}	(Notes 1, 2)	CE# = V _{IL} , OE# = V _{IH}	1 MHz		2	4	mA
I _{CC2}	V _{CC} Active Write Current (Notes 2, 3, 4)	CE# = V _{IL,} OE# = V _{IH}			15	30	mA
I _{CC3}	V _{CC} Standby Current (Note 2)	$CE# = V_{CC} \pm 0.3 \text{ V}$			0.2	5	μA
I _{CC4}	V _{CC} Reset Current (Note 2)				0.2	5	μA
I _{CC5}	Automatic Sleep Mode (Notes 2, 5)	$V_{IH} = V_{CC} \pm 0.3 \text{ V};$ $V_{IL} = V_{SS} \pm 0.3 \text{ V}$			0.2	5	μA
V _{IL}	Input Low Voltage			-0.5		0.8	V
V _{IH}	Input High Voltage			0.7 x V _{CC}		V _{CC} + 0.3	V
V _{ID}	Voltage for Autoselect and Temporary Sector Unprotect	V _{CC} = 3.3 V		11.5		12.5	٧
V _{OL}	Output Low Voltage	$I_{OL} = 4.0 \text{ mA}, V_{CC} = V_{CO}$	C min			0.45	V
V _{OH1}	Outrot High Valtage	$I_{OH} = -2.0 \text{ mA}, V_{CC} = V$	CC min	0.85 V _{CC}			V
V _{OH2}	Output High Voltage	$I_{OH} = -100 \ \mu A, \ V_{CC} = V$	CC min	V _{CC} -0.4			
V _{LKO}	Low V _{CC} Lock-Out Voltage (Note 4)			2.3		2.5	V

- 1. The I $_{\rm CC}$ current listed is typically less than 2 mA/MHz, with OE# at V $_{\rm IH}$. Typical V $_{\rm CC}$ is 3.0 V.
- 2. Maximum I_{CC} current specifications are tested with V_{CC}=V_{CC} max.
- 3. I_{CC} active while Embedded Erase or Embedded Program is in progress.
- 4. Not 100% tested.
- 5. Automatic sleep mode enables the low power mode when addresses remain stable for t_{ACC} + 30 ns.



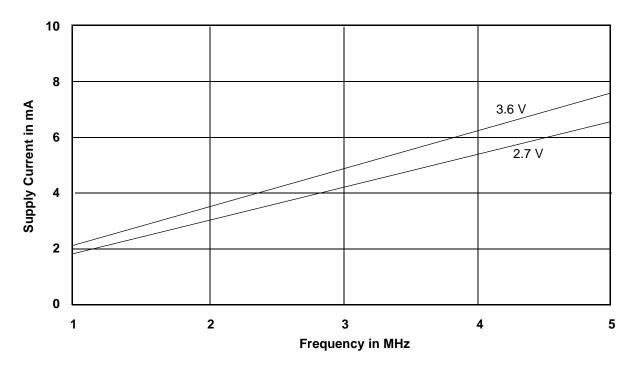
DC CHARACTERISTICS (continued)

Zero Power Flash



Note: Addresses are switching at 1 MHz

Figure 7. I_{CC1} Current vs. Time (Showing Active and Automatic Sleep Currents)



Note: $T = 25 \,^{\circ}C$

Figure 8. Typical I_{CC1} vs. Frequency



TEST CONDITIONS

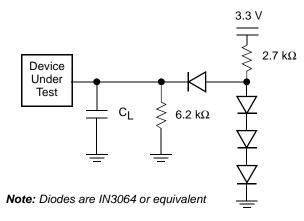


Figure 9. Test Setup

Table 6. Test Specifications

Test Condition	-60R, -70	-90, -120	Unit
Output Load	1	TTL gate	
Output Load Capacitance, C _L (including jig capacitance)	30	100	pF
Input Rise and Fall Times	5		ns
Input Pulse Levels	0.0-3.0		٧
Input timing measurement reference levels	1.5		٧
Output timing measurement reference levels	1.5		٧

KEY TO SWITCHING WAVEFORMS

WAVEFORM	INPUTS	OUTPUTS	
	Steady		
	Cha	anging from H to L	
_////	Changing from L to H		
XXXXX	Don't Care, Any Change Permitted	Changing, State Unknown	
\longrightarrow \longleftarrow	Does Not Apply	Center Line is High Impedance State (High Z)	

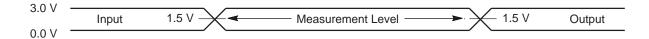


Figure 10. Input Waveforms and Measurement Levels



Read Operations

Param	arameter		Speed Option							
JEDEC	Std	Desc	cription	Test Set	up	-60R	-70	-90	-120	Unit
t _{AVAV}	t _{RC}	Read Cycle Time (No	te 1)		Min	60	70	90	120	ns
t _{AVQV}	t _{ACC}	Address to Output Delay		CE# = V _{IL} OE# = V _{IL}	Max	60	70	90	120	ns
t _{ELQV}	t _{CE}	Chip Enable to Output Delay		OE# = V _{IL}	Max	60	70	90	120	ns
t _{GLQV}	t _{OE}	Output Enable to Output Delay			Max	30	30	35	50	ns
t _{EHQZ}	t _{DF}	Chip Enable to Output High Z (Note 1)			Max	16			ns	
t _{GHQZ}	t _{DF}	Output Enable to Out	put High Z (Note 1)		Max	16			ns	
		Outrut Fachla	Read		Min		(0		ns
	t _{OEH}	Output Enable Hold Time (Note 1)	Toggle and Data# Polling		Min		1	0		ns
t _{AXQX}	t _{OH}	Output Hold Time From Addresses, CE# or OE#, Whichever Occurs First (Note 1)			Min	0			ns	

- 1. Not 100% tested.
- 2. See Figure 9 and Table 6 for test specifications.

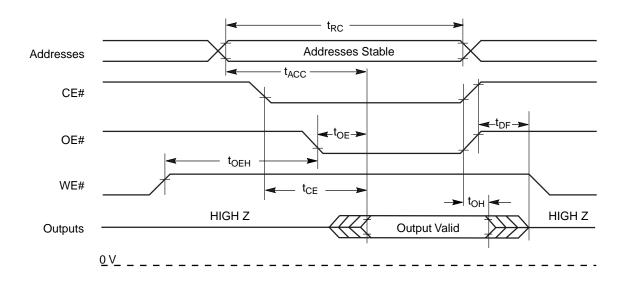


Figure 11. Read Operations Timings

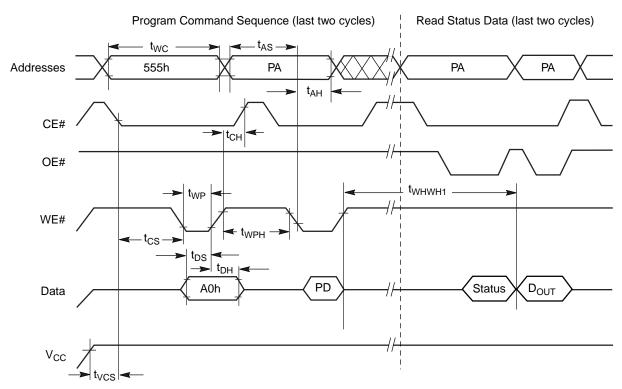


Erase/Program Operations

Parameter					Speed	Options		
JEDEC	Std	Description		-60R	-70	-90	-120	Unit
t _{AVAV}	t _{WC}	Write Cycle Time (Note 1)	Min	60	70	90	120	ns
t _{WLAX}	t _{AH}	Address Hold Time	Min	45	45	45	50	ns
t _{DVWH}	t _{DS}	Data Setup Time	Min	35	35	45	50	ns
t _{WLWH}	t _{WP}	Write Pulse Width	Min	35	35	35	50	ns
t _{AVWL}	t _{AS}	Address Setup Time	Min		()		ns
t _{WHDX}	t _{DH}	Data Hold Time	Min	0			ns	
	t _{OES}	Output Enable Setup Time	Min	0			ns	
t _{GHWL}	t _{GHWL}	Read Recovery Time Before Write (OE# High to WE# Low)	Min	0			ns	
t _{ELWL}	t _{CS}	CE# Setup Time	Min		()		ns
t _{WHEH}	t _{CH}	CE# Hold Time	Min		()		ns
t _{WHWL}	t _{WPH}	Write Pulse Width High	Min	30			ns	
t _{WHWH1}	t _{WHWH1}	Programming Operation (Note 2)	Тур	9		μs		
t _{WHWH2}	t _{WHWH2}	Sector Erase Operation (Note 2)	Тур	0.7		sec		
	t _{VCS}	V _{CC} Setup Time (Note 1)	Min		5	0		μs

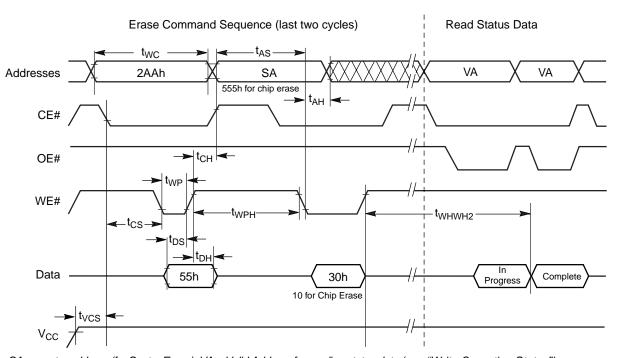
- 1. Not 100% tested.
- 2. See the "Erase and Programming Performance" section for more information.





Note: $PA = program \ address, PD = program \ data, D_{OUT}$ is the true data at the program address.

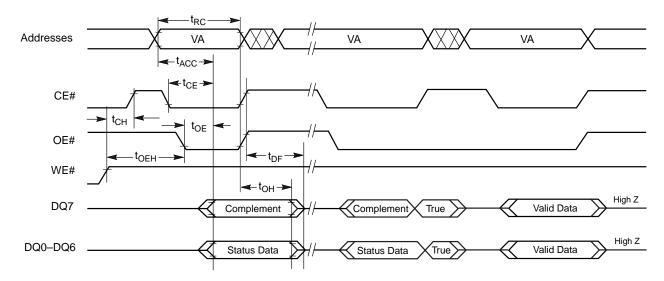
Figure 12. Program Operation Timings



Note: SA = sector address (for Sector Erase), VA = Valid Address for reading status data (see "Write Operation Status").

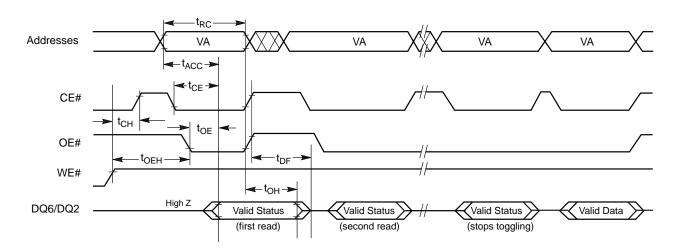
Figure 13. Chip/Sector Erase Operation Timings





Note: VA = Valid address. Illustration shows first status cycle after command sequence, last status read cycle, and array data read cycle.

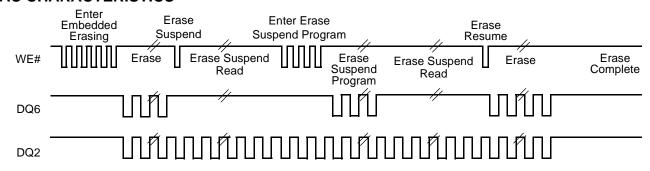
Figure 14. Data# Polling Timings (During Embedded Algorithms)



Note: VA = Valid address; not required for DQ6. Illustration shows first two status cycle after command sequence, last status read cycle, and array data read cycle.

Figure 15. Toggle Bit Timings (During Embedded Algorithms)





Note: The system may use CE# or OE# to toggle DQ2 and DQ6. DQ2 toggles only when read at an address within an erase-suspended sector.

Figure 16. DQ2 vs. DQ6

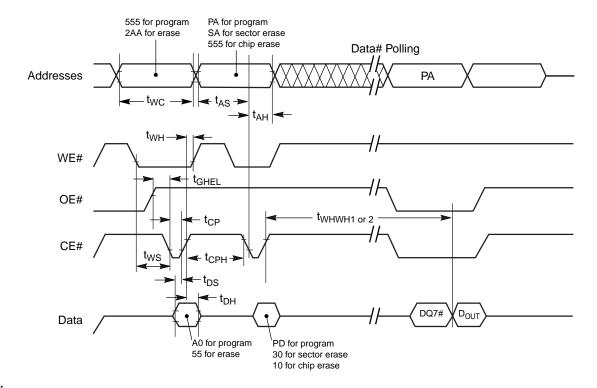


Alternate CE# Controlled Erase/Program Operations

Parameter					Speed	Options		
JEDEC	Std	Description		-60R	-70	-90	-120	Unit
t _{AVAV}	t _{WC}	Write Cycle Time (Note 1)	Min	60	70	90	120	ns
t _{ELAX}	t _{AH}	Address Hold Time	Min	45	45	45	50	ns
t _{DVEH}	t _{DS}	Data Setup Time	Min	35	35	45	50	ns
t _{ELEH}	t _{CP}	CE# Pulse Width	Min	35	35	35	50	ns
t _{AVEL}	t _{AS}	Address Setup Time	Min		()		ns
t _{EHDX}	t _{DH}	Data Hold Time	Min	0			ns	
	t _{OES}	Output Enable Setup Time	Min		()		ns
t _{GHEL}	t _{GHEL}	Read Recovery Time Before Write (OE# High to WE# Low)	Min	0			ns	
t _{WLEL}	t _{WS}	WE# Setup Time	Min		()		ns
t _{EHWH}	t _{WH}	WE# Hold Time	Min	0			ns	
t _{EHEL}	t _{CPH}	CE# Pulse Width High	Min	30		ns		
t _{WHWH1}	t _{WHWH1}	Programming Operation (Note 2)	Тур		,	9		μs
t _{WHWH2}	t _{WHWH2}	Sector Erase Operation (Note 2)	Тур		0	.7		sec

- 1. Not 100% tested.
- 2. See the "Erase and Programming Performance" section for more information.





- PA = Program Address, PD = Program Data, DQ7# = complement of the data written to the device, D_{OUT} is the data written to the device.
- 2. Figure indicates the last two bus cycles of the command sequence.

Figure 17. Alternate CE# Controlled Write Operation Timings



ERASE AND PROGRAMMING PERFORMANCE

Parameter	Typ (Note 1)	Max (Note 2)	Unit	Comments
Sector Erase Time	0.7	15	S	Excludes 00h programming
Chip Erase Time	11		S	prior to erasure (Note 4)
Byte Programming Time	9	300	μs	
Chip Programming Time (Note 3)	4.5	13.5	S	Excludes system level overhead (Note 5)

Notes:

- Typical program and erase times assume the following conditions: 25°C, 3.0 V V_{CC}, 1,000,000 cycles. Additionally, programming typicals assume checkerboard pattern.
- 2. Under worst case conditions of 90°C, $V_{CC} = 2.7 \text{ V}$ (3.0 V for -60R), 1,000,000 cycles.
- 3. The typical chip programming time is considerably less than the maximum chip programming time listed, since most bytes program faster than the maximum program times listed.
- 4. In the pre-programming step of the Embedded Erase algorithm, all bytes are programmed to 00h before erasure.
- 5. System-level overhead is the time required to execute the two- or four-bus-cycle sequence for the program command. See Table 4 for further information on command definitions.
- 6. The device has a minimum guaranteed erase and program cycle endurance of 1,000,000 cycles.

LATCHUP CHARACTERISTICS

Description	Min	Max
Input voltage with respect to V _{SS} on all pins except I/O pins (including A9 and OE#)	–1.0 V	12.5 V
Input voltage with respect to V _{SS} on all I/O pins	–1.0 V	V _{CC} + 1.0 V
V _{CC} Current	–100 mA	+100 mA

Includes all pins except V_{CC} . Test conditions: $V_{CC} = 3.0 \text{ V}$, one pin at a time.

TSOP AND SO PIN CAPACITANCE

Parameter Symbol	Parameter Description	Test Setup	Тур	Max	Unit
C _{IN}	Input Capacitance	V _{IN} = 0	6	7.5	pF
C _{OUT}	Output Capacitance	V _{OUT} = 0	8.5	12	pF
C _{IN2}	Control Pin Capacitance	V _{IN} = 0	7.5	9	pF

Notes:

- 1. Sampled, not 100% tested.
- 2. Test conditions $T_A = 25$ °C, f = 1.0 MHz.

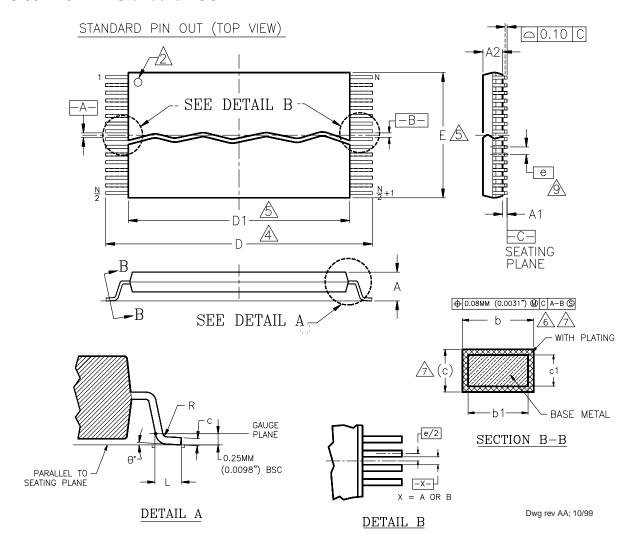
DATA RETENTION

Parameter	Test Conditions	Min	Unit
Minimum Pattern Data Retention Time	150°C	10	Years
Millimum Pattern Data Retention Time	125°C	20	Years



PHYSICAL DIMENSIONS*

TS 032—32-Pin Standard TSOP



Package		TS 32			
Jedec	MO-1	MO-142 (B) BD			
Symbol	MIN	NDM	MAX		
А	_	_	1.20		
A1	0.05	_	0.15		
A2	0.95	1.00	1.05		
b1	0.17	0.20	0.23		
b	0.17	0.22	0.27		
c 1	0.10	_	0.16		
С	0.10	_	0.21		
D	19.80	20.00	20.20		
D1	18.30	18.40	18.50		
E	7.90	8.00	8.10		
е	0.50 BASIC				
L	0.50	0.60	0.70		
θ	0°	3°	5°		
R	0.08	_	0.20		
N	32				

NOTES:

1. CONTROLLING DIMENSIONS ARE IN MILLIMETERS (mm).

(DIMENSIONING AND TOLERANCING CONFORMS TO ANSI Y14.5M-1982)

∕2. `PIN 1 IDENTIFIER FOR STANDARD PIN OUT (DIE UP).

PIN 1 IDENTIFIER FOR REVERSE PIN OUT (DIE DOWN): INK OR LASER MARK.

TO BE DETERMINED AT THE SEATING PLANE <u>—C—</u>. THE SEATING PLANE IS

DEFINED AS THE PLANE OF CONTACT THAT IS MADE WHEN THE PACKAGE LEADS

ARE ALLOWED TO REST FREELY ON A FLAT HORIZONTAL SURFACE.

DIMENSIONS DI AND E DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE MOLD PROTUSION IS 0.15mm (.0059*) PER SIDE.

DIMENSION 6 DOES NOT INCLUDE DAMBAR PROTUSION. ALLOWABLE DAMBAR PROTUSION SHALL BE 0.08mm (0.0031") TOTAL IN EXCESS OF 6 DIMENSION AT MAX. MATERIAL CONDITION. MINIMUM SPACE BETWEEN PROTRUSION AND AN ADJACENT LEAD TO BE 0.07mm (0.0028").

THESE DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN 0.10mm (.0039") AND 0.25mm (0.0098") FROM THE LEAD TIP.

8. LEAD COPLANARITY SHALL BE WITHIN 0.10mm (0.004") AS MEASURED FROM THE SEATING PLANE.

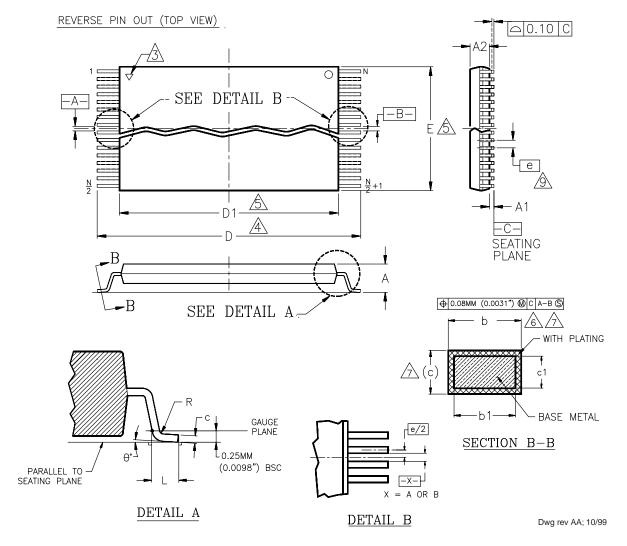
 $\cancel{9}$ DIMENSION "e" IS MEASURED AT THE CENTERLINE OF THE LEADS.

^{*} For reference only. BSC is an ANSI standard for Basic Space Centering.



PHYSICAL DIMENSIONS

TSR032—32-Pin Reverse TSOP



Package	TSR32				
Jedec	MO-1	MO-142 (B) BD			
Symbol	MIN	NDM	MAX		
А	_	_	1.20		
A1	0.05	_	0.15		
A2	0.95	1.00	1.05		
b1	0.17	0.20	0.23		
b	0.17	0.22	0.27		
⊂1	0.10	_	0.16		
С	0.10	_	0.21		
D	19.80	20.00	20.20		
D1	18.30	18.40	18.50		
E	7.90	8.00	8.10		
е	0.50 BASIC				
L	0.50	0.60	0.70		
θ	0,	3°	5°		
R	0.08	_	0.20		
N	32				

NOTES:

1 CONTROLLING DIMENSIONS ARE IN MILLIMETERS (mm).

(DIMENSIONING AND TOLERANCING CONFORMS TO ANSI Y14.5M-1982)

PIN 1 IDENTIFIER FOR STANDARD PIN OUT (DIE UP).

PIN 1 IDENTIFIER FOR REVERSE PIN OUT (DIE DOWN): INK OR LASER MARK.

/1 TO BE DETERMINED AT THE SEATING PLANE [-C]. THE SEATING PLANE IS DEFINED AS THE PLANE OF CONTACT THAT IS MADE WHEN THE PACKAGE LEADS ARE ALLOWED TO REST FREELY ON A FLAT HORIZONTAL SURFACE.

DIMENSIONS D1 AND E DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE MOLD PROTUSION IS 0.15mm (.0059*) PER SIDE.

DIMENSION 6 DOES NOT INCLUDE DAMBAR PROTUSION, ALLOWABLE DAMBAR PROTUSION SHALL BE 0.08mm (0.0031") TOTAL IN EXCESS OF 6 DIMENSION AT MAX. MATERIAL CONDITION, MINIMUM SPACE BETWEEN PROTRUSION AND AN ADJACENT LEAD TO BE 0.07mm (0.0028").

THESE DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN 0.10mm (.0039") AND 0.25mm (0.0098") FROM THE LEAD TIP.

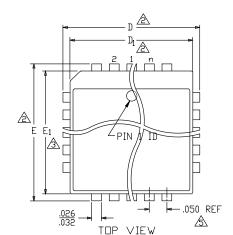
8. LEAD COPLANARITY SHALL BE WITHIN 0.10mm (0.004") AS MEASURED FROM THE SEATING PLANE.

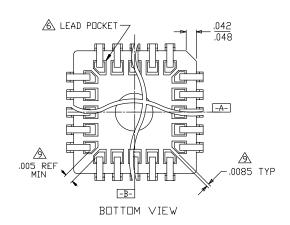
DIMENSION "e" IS MEASURED AT THE CENTERLINE OF THE LEADS.

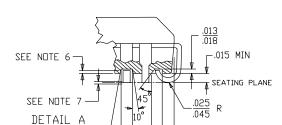
^{*} For reference only. BSC is an ANSI standard for Basic Space Centering.

PHYSICAL DIMENSIONS

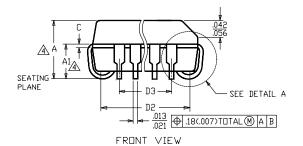
PL 032—32-Pin Plastic Leaded Chip Carrier







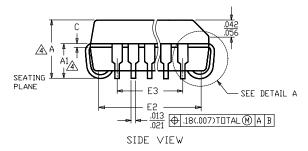
.023



.066

.072

.026



PACKAGE	PL32		
JEDEC	MD-05	52(A)AE	
SYMBOL	MIN	MAX	
А	.125	.140	
A1	.080	.095	
\mathbb{D}	.485	.495	
D1	.447	.453	
D2	.390	.430	
D3	.300	REF	
Ε	.585	.595	
E1	.547	.553	
E2	.490	.530	
E3	.400	REF	
С	.009	.015	

NOTES:

Dwg rev AH; 10/99

1. ALL DIMENSIONS ARE IN INCHES.

PL 032

- DIMENSIONS "D" AND "E" ARE MEASURED FROM OUTERMOST POINT.
- △ DIMENSIONS D1 AND E1 DO NOT INCLUDE CORNER MOLD FLASH. ALLOWABLE CORNER MOLD FLASH IS .010"
- ADJIMENSIONS "A", "A1", "D2" AND "E2" ARE
 MEASURED AT THE POINTS OF CONTACT TO BASE PLANE
- LEAD SPACING AS MEASURED FROM CENTERLINE
- TO CENTERLINE SHALL BE WITHIN ±.005".

 J-LEAD TIPS SHOULD BE LOCATED INSIDE
- THE "POCKET.

 7. LEAD COPLANARITY SHALL BE WITHIN .004" AS
- 7. LEAD COPLANARITY SHALL BE WITHIN .004" AS MEASURED FROM SEATING PLANE, COPLANARITY IS MEASURED PER AMD 06-500.
- 8. LEAD TWEEZE SHALL BE WITHIN .0045" ON EACH SIDE AS MEASURED FROM A VERTICAL FLAT PLANE. TWEEZE IS MEASURED PER AMD 06-500.
- LEAD POCKET MAY BE RECTANGULAR (AS SHOWN) OR OVAL.

 IF CORNER LEAD POCKETS ARE CONNECTED THEN 5 MILS

 MINIMUM CORNER LEAD SPACING IS REQUIRED.



REVISION SUMMARY

Revision A (January 1998)

Revision B (April 1998)

Expanded data sheet from Advanced Information to Preliminary version.

Revision B+1 (November 1998)

Connection Diagrams

Corrected the standard TSOP pinout.

Revision C (January 1999)

Distinctive Characteristics

Added 20-year data retention subbullet.

Revision C+1 (May 18, 1999)

Removed preliminary designation from data sheet.

Revision C+2 (July 20, 1999)

Physical Dimensions

Corrected the unit of measurement for the 32-pin PLCC to inches.

Revision D (November 11, 1999)

Global

Changed all references to 55R speed option (55 ns, regulated voltage range) to 60R (60 ns, regulated voltage range).

Physical Dimensions

Replaced all drawings with new versions.

AC Characteristics—Figure 12. Program Operations Timing and Figure 13. Chip/Sector Erase Operations

Deleted t_{GHWL} and changed OE# waveform to start at high.

Revision D+1 (November 13, 2000)

Global

Added table of contents. Deleted burn-in option from Ordering Information section.

Revision E (March 12, 2003)

Distinctive Characteristics

Corrected the values for the automatic sleep mode and standby mode.

Command Definitions

Added new global text to first paragraph.

Byte/Word Program Command Sequence, Sector Erase Command Sequence, and Chip Erase Command Sequence

Noted that the autoselect function is unavailable when a program or erase operation is in progress.

Read Operations

Changed the $t_{\mbox{\footnotesize EHQZ}}$ and $t_{\mbox{\footnotesize GHQZ}}$ max to 16 ns for all speed options.

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